Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/026,172	FUJISAWA ET AL.	
Examiner	Art Unit	
Pierre-Louis Desir	2681	

SEARCHED				
Class	Subclass	Date	Examiner	
455	88	11/9/2006	PD	
340	5.61	11/9/2006	PD	
340	5.1	11/9/2006	PD	
360	10	11/9/2006	PD	
702	179	11/9/2006	PD	
368	108	11/9/2006	PD	
368	13	11/9/2006	PD	
		·		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
455	88	11/9/2006	PD		
360	10	11/9/2006	PD		
702	179	11/9/2006	PD		
368/13, 108		11/9/2006	PD		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	11/9/2006	PD	
Steve D'Agosta	11/7/2006	PD	
Tommy Chin	11/8/2006	PD	
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